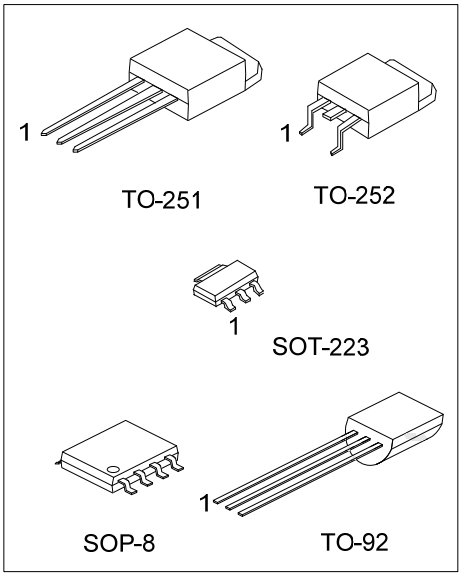
1N65Q-TA

Power MOSFET

1.0A, 650V N-CHANNEL POWER MOSFET



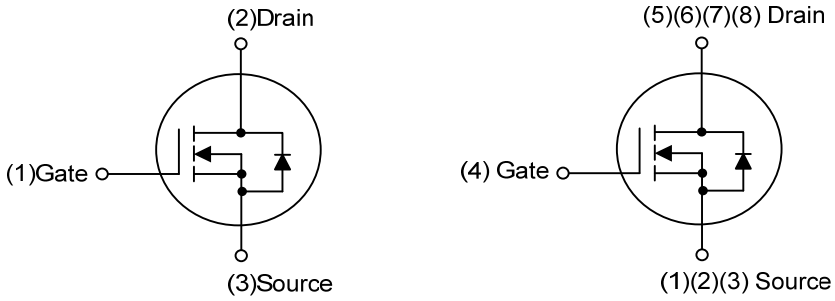
■ DESCRIPTION

The UTC **1N65Q-TA** is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

■ FEATURES

* $R_{DS(ON)} \leq 9.5\ \Omega$ @ V_{GS}=10V, I_D=0.5A
* Fast switching capability
* Avalanche energy specified
* Improved dv/dt capability, high ruggedness

■ SYMBOL

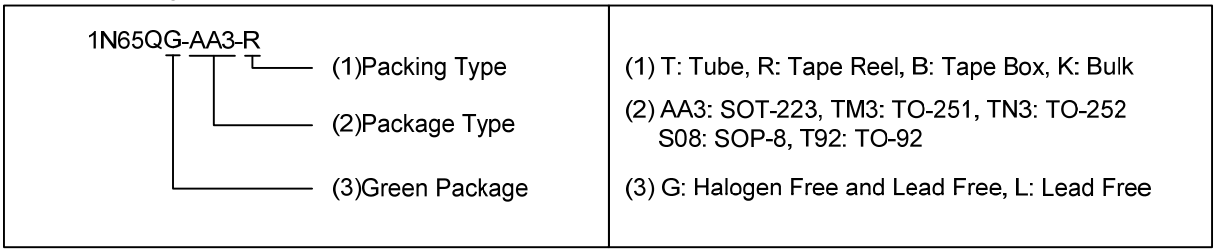


TO-251/TO-252/TO-92 SOP-8

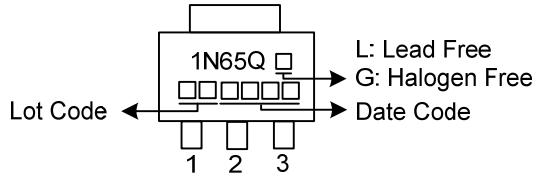
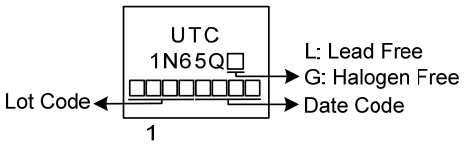
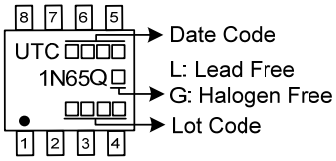
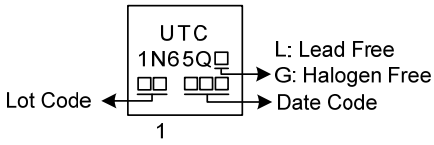
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
1N65QL-AA3-R	1N65QG-AA3-R	SOT-223	G	D	S	-	-	-	-	-	Tape Reel
1N65QL-TM3-T	1N65QG-TM3-T	TO-251	G	D	S	-	-	-	-	-	Tube
1N65QL-TN3-R	1N65QG-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
1N65QL-S08-R	1N65QG-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel
1N65QL-T92-B	1N65QG-T92-B	TO-92	G	D	S	-	-	-	-	-	Tape Box
1N65QL-T92-K	1N65QG-T92-K	TO-92	G	D	S	-	-	-	-	-	Bulk

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING

SOT-223	TO-251 / TO-252
	
SOP-8	**TO-92**
	

■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current	Continuous	I_D	1	A
Pulsed Drain Current (Note 2)	Pulsed (Note 2)	I_{DM}	2	A
Avalanche Current (Note 2)		I_{AR}	1	A
Avalanche Energy (Note 3)	Single Pulsed	E_{AS}	25	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.1	V/ns
Power Dissipation	SOT-223	P_D	2.2	W
	TO-251/TO-252		26	W
	SOP-8		2.1	W
	TO-92		1.42	W
Junction Temperature		T_J	+150	°C
Storage Temperature		T_{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature.
3. L=30mH, I_{AS}=1.3A, V_{DD}=50V, R_G=25 Ω, Starting T_J = 25°C
4. I_{SD}≤1.0A, di/dt≤200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C

■ THERMAL DATA (Note)

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	SOT-223	$θ_{JA}$	150	°C/W
	TO-251/TO-252		110	°C/W
	SOP-8		90	°C/W
	TO-92		160	°C/W
Junction to Case	SOT-223	$θ_{JC}$	56.8	°C/W
	TO-251/TO-252		4.8	°C/W
	SOP-8		59.5	°C/W
	TO-92		88	°C/W

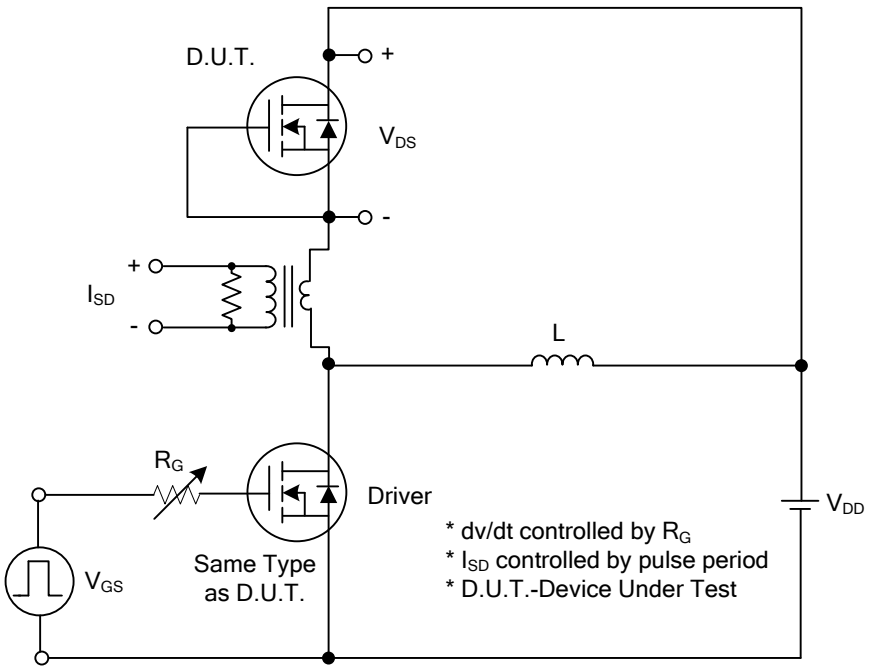
Note: The data tested by surface mounted on a 1 inch^2 FR-4 board with 2OZ copper.

■ ELECTRICAL CHARACTERISTICS (T_C =25°C, unless otherwise specified)

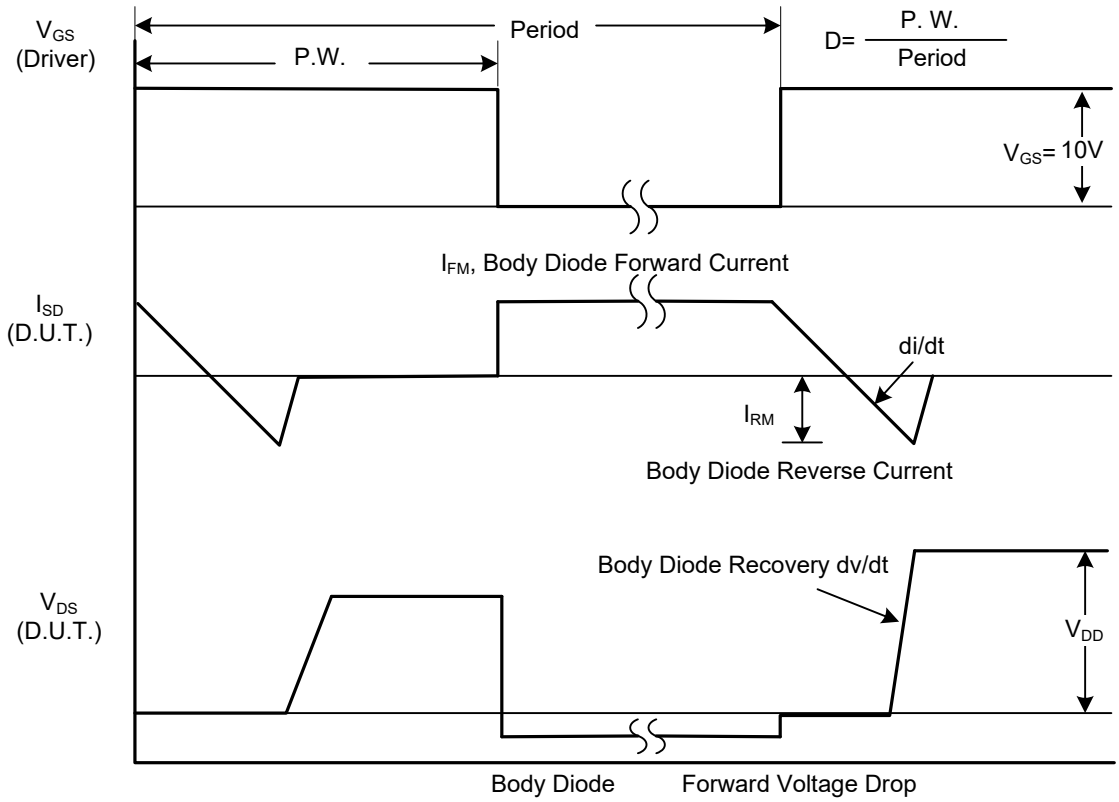
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} = 0V, I_D = 250μA	650			V
Drain-Source Leakage Current		I_{DSS}	V_{DS} = 650V, V_{GS} = 0V			10	μA
Gate-Source Leakage Current	Forward	I_{GSS}	V_{GS} = 30V, V_{DS} = 0V			100	nA
	Reverse		V_{GS} = -30V, V_{DS} = 0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	V_{DS} = V_{GS}, I_D = 250μA	2.0		4.0	V
Static Drain-Source On-State Resistance		$R_{DS(ON)}$	V_{GS} = 10V, I_D =0.5A			9.5	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C_{ISS}	V_{DS} =25V, V_{GS} =0V, f =1MHz		160		pF
Output Capacitance		C_{OSS}			21		pF
Reverse Transfer Capacitance		C_{RSS}			2		pF
SWITCHING CHARACTERISTICS							
Total Gate Charge		Q_G	V_{DS}=520V, V_{GS}=10V, I_D=1.0A (Note 1, 2)		10		nC
Gate-Source Charge		Q_{GS}			4		nC
Gate-Drain Charge		Q_{GD}			1.2		nC
Turn-On Delay Time		$t_{D\ (ON)}$	V_{DD} =100V, V_{GS}=10V, I_D=1.0A, R_G=25Ω (Note 1, 2)		5		ns
Turn-On Rise Time		t_R			16		ns
Turn-Off Delay Time		$t_{D(OFF)}$			16.5		ns
Turn-Off Fall Time		t_F			40		ns
DRAIN-SOURCE DIODE CHARACTERISTICS							
Maximum Body-Diode Continuous Current		I_S				1	A
Maximum Body-Diode Pulsed Current		I_{SM}				2	A
Drain-Source Diode Forward Voltage		V_{SD}	V_{GS} = 0 V, I_{SD} = 1.0 A			1.4	V
Reverse Recovery Time		t_{rr}	I_F=1.0A, V_{DD}=100V di/dt = 100A/μs		148		ns
Reverse Recovery Charge		Q_{rr}			437		nC

Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle≤2%
2. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

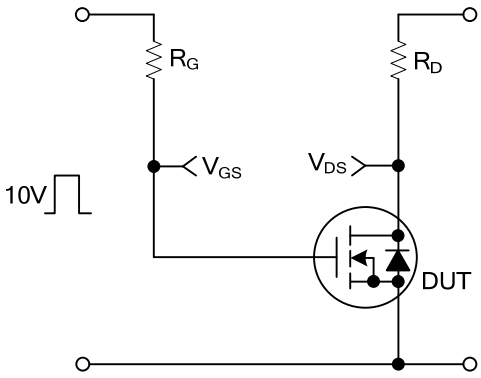


Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS



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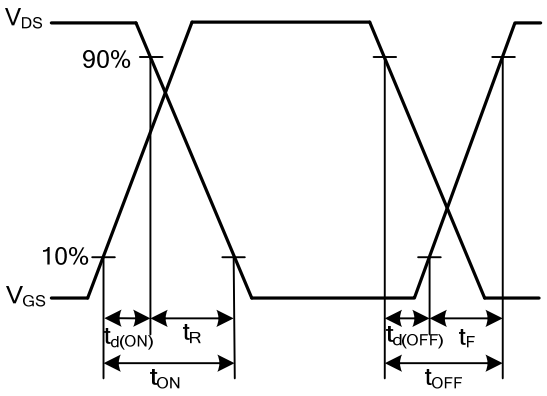
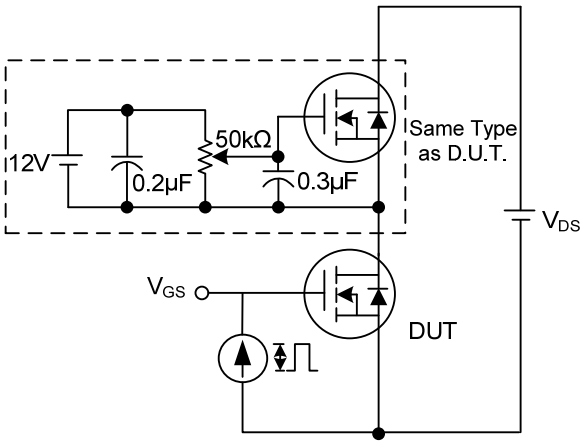
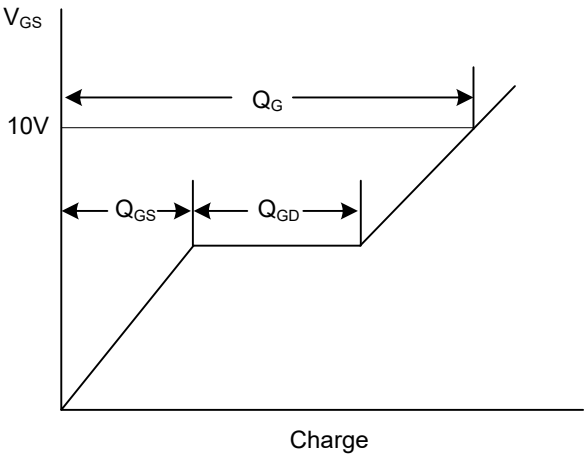


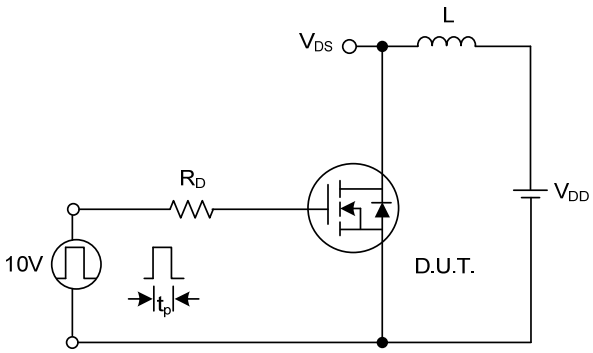
Switching Waveforms



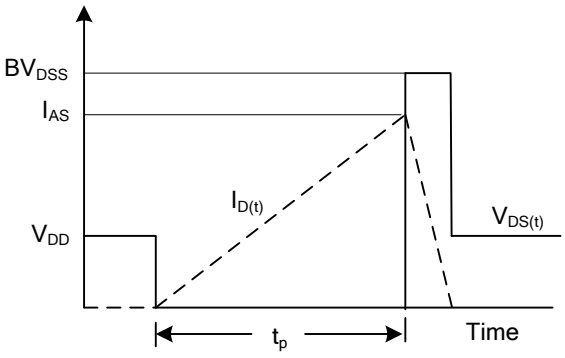
Gate Charge Test Circuit



Gate Charge Waveform

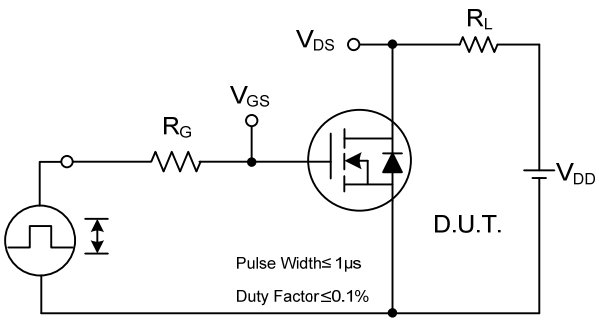


Unclamped Inductive Switching Test Circuit

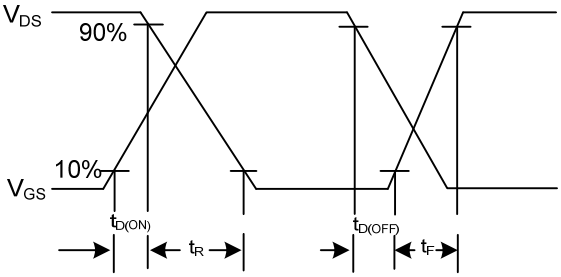


Unclamped Inductive Switching Waveforms

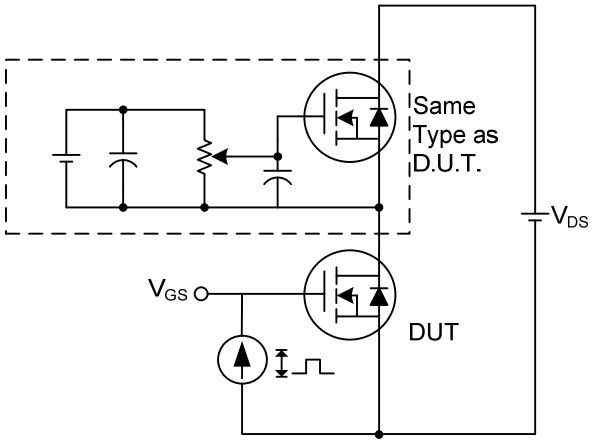
■ TEST CIRCUITS AND WAVEFORMS



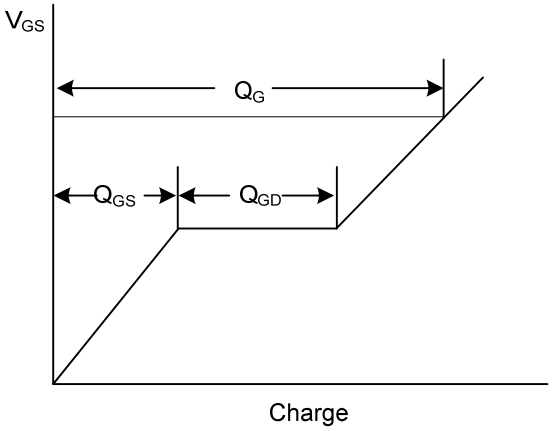
Switching Test Circuit



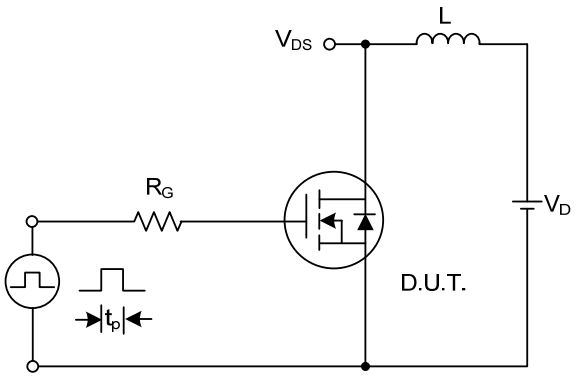
Switching Waveforms



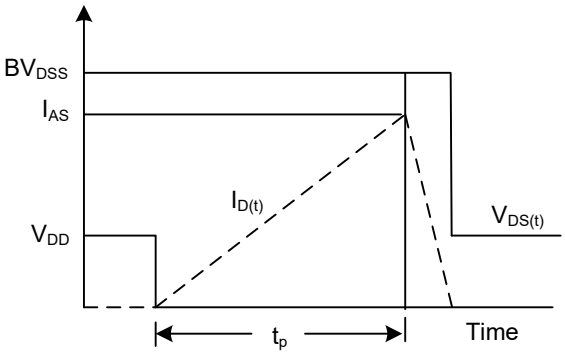
Gate Charge Test Circuit



Gate Charge Waveform



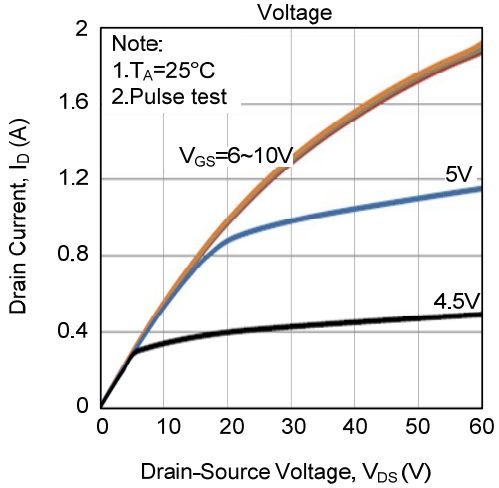
Unclamped Inductive Switching Test Circuit



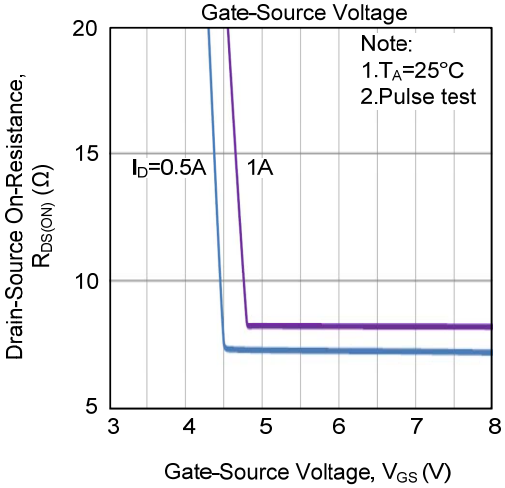
Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS

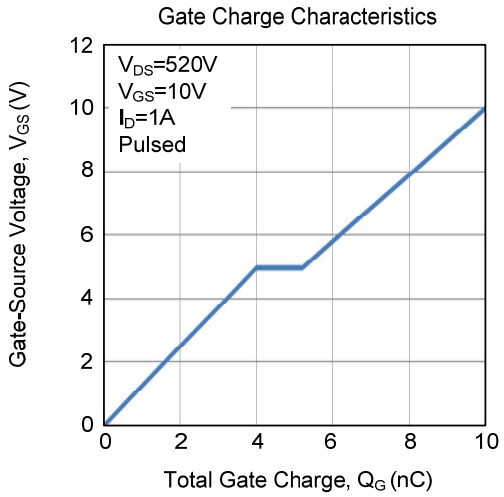
Drain Current vs. Drain-Source Voltage



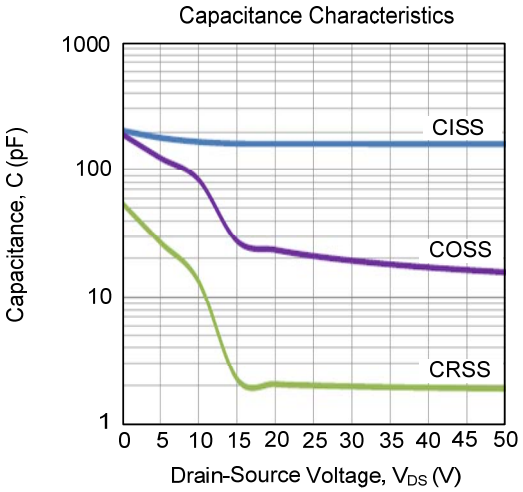
Drain-Source On-Resistance vs. Gate-Source Voltage



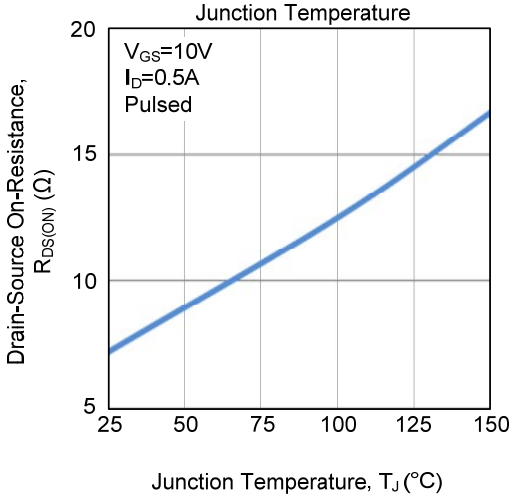
Gate Charge Characteristics



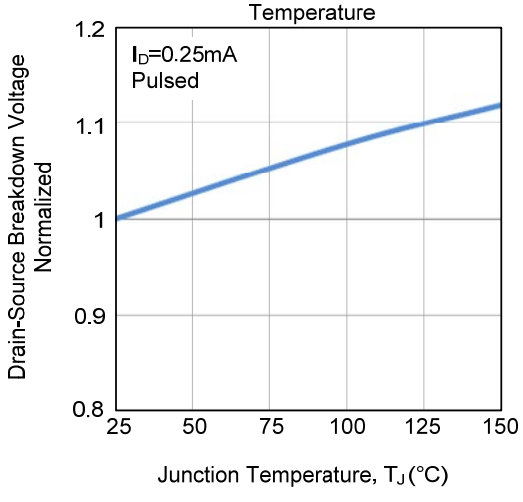
Capacitance Characteristics



Drain-Source On-Resistance vs. Junction Temperature

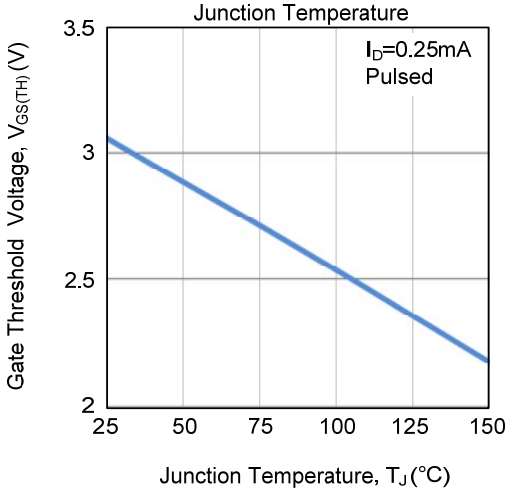


Breakdown Voltage vs. Junction Temperature

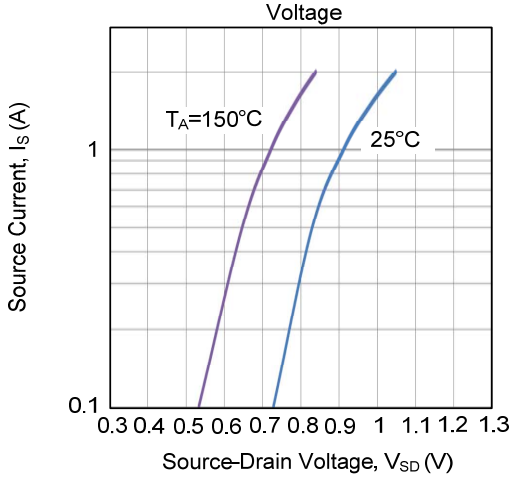


■ TYPICAL CHARACTERISTICS (Cont.)

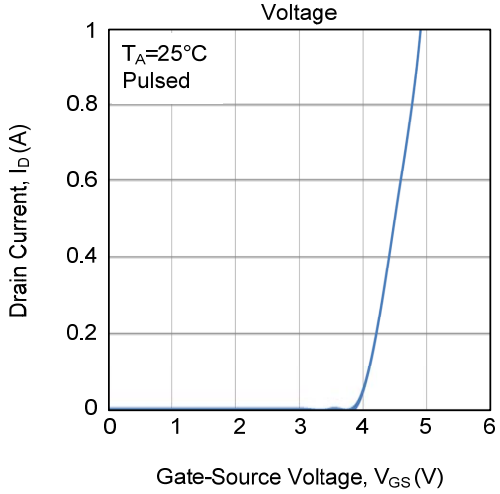
Gate Threshold Voltage vs. Junction Temperature



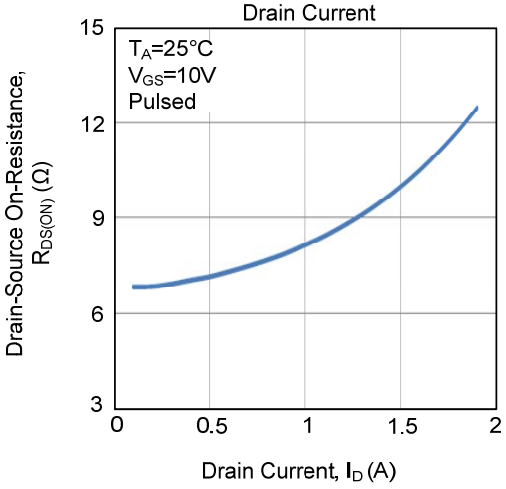
Source Current vs. Source-Drain Voltage



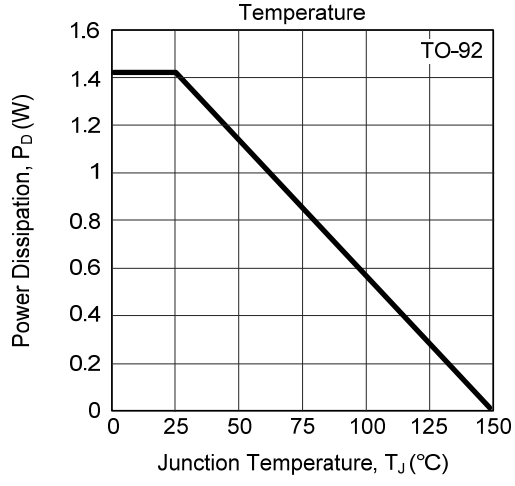
Drain Current vs. Gate-Source Voltage



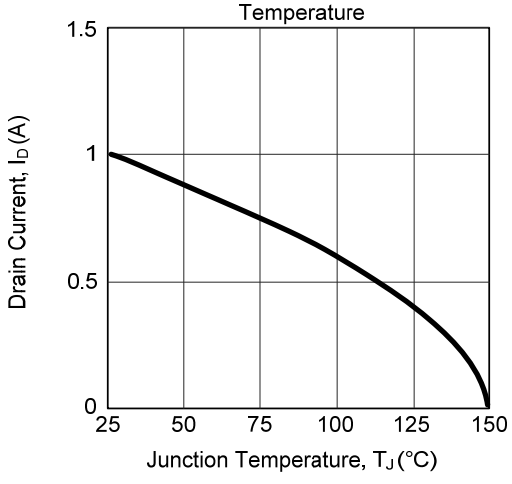
Drain-Source On-Resistance vs. Drain Current



Power Dissipation vs. Junction Temperature



Drain Current vs. Junction Temperature



■ TYPICAL CHARACTERISTICS (Cont.)